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PATENT  
Customer No. 22,852  
Attorney Docket No. 2849-124

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of: )  
Jouko Kinnunen et al. ) Group Art Unit: 2858  
Application No.: 10/653,203 ) Examiner: To be Assigned  
Filed: September 3, 2003 )  
For: RF Testing Method and ) Confirmation No.: 2604  
Arrangement )

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

**INFORMATION DISCLOSURE STATEMENT**

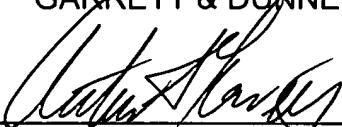
Enclosed for the consideration of the Examiner in connection with the prosecution of this application is a PTO Form SB/08 listing eight references cited in the International Search Report of the corresponding International application.

Copies of the non-U.S. patent documents are enclosed.

If there is any fee due in connection with the filing of this Statement, please charge such fee to our deposit account 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW,  
GARRETT & DUNNER, L.L.P.

By: 

Arthur S. Garrett  
Reg. No. 20,338

Dated: January 24, 2005

# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

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of

Complete if Known	
Application Number	10/653,203
Filing Date	September 3, 2003
First Named Inventor	Jouko Kinnunen et al.
Art Unit	2858
Examiner Name	To be Assigned
Attorney Docket Number	2849-124

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U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Initials	Cite No. <sup>1</sup>	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
		US-2002/0196029 A1	12/26/02	Dominik J. Schmidt	
		US-6,466,007 B1	10/15/02	Homem Cristo Prazeres da Costa	
		US-5,517,491	05/14/96	Peter Nanni	
		US-6,324,655 B1	11/27/01	Thomas R. Fay	
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		US-2002/0093358	07/18/02	Kyung Suk Kang	

Note: Copies of the U.S. Patent Documents are not Required in IDS filed after October 21, 2004

## FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation <sup>6</sup>
		Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)				
		EP 1 215 822 A1	06/19/02	Nokia Corporation		
		EP 1 223 432 A1	07/17/02	Telefonaktiebolaget L M. Ericsson		

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation <sup>6</sup>

Examiner Signature	Date Considered
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.